

<TRANSISTOR ARRAY>

# M54562FP

8-UNIT 500mA DARLINGTON TRANSISTOR ARRAY WITH CLAMP DIODE SOURCE TYPE

#### DESCRIPTION

M54562FP is an eight-circuit output-sourcing darlington transistor array. The circuits are made of PNP and NPN transistors. This semiconductor integrated circuit performs high current driving with extremely low input-current supply.

#### FEATURES

- High breakdown voltage (BVCEO 
  <u>></u> 50V)
- High-current driving (lo(max) = -500mA)
- With clamping diodes
- Driving available with PMOS IC output of 6 ~ 16V or with TTL output
- Output current-sourcing type

#### APPLICATIONS

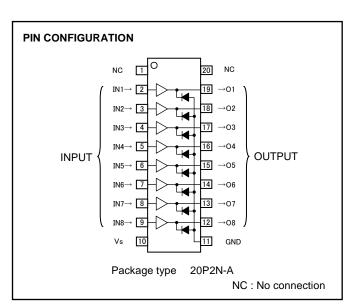
Drives of relays, printers, LEDs, fluorescent display tubes and lamps, and interfaces between MOS-bipolar logic systems and relays, solenoids, or small motors.

#### FUNCTION

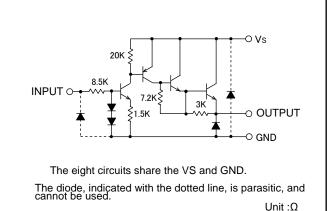
The M54562FP each have eight circuits, which are made of input inverters and current-sourcing outputs.

The outputs are made of PNP transistors and NPN Darlington transistors. The PNP transistor base current is constant. A clamping diode is provided between each output and GND. VS and GND are used commonly among the eight circuits.

The inputs have resistance of  $8.5k\Omega$ , and voltage of up to 30V is applicable. Output current is 500 mA maximum. Supply voltage VS is 50V maximum.



#### CIRCUIT DIAGRAM



#### **ABSOLUTE MAXIMUM RATINGS** (Unless otherwise noted, $Ta = -20 \sim +75^{\circ}$ C)

Symbol	Parameter	Conditions	Ratings	Unit
VCEO #	Collector-emitter voltage	Output , L	-0.5 ~ +50	V
Vs	Supply voltage		50	V
Vi	Input voltage		-0.5 ~ +30	V
lo	Output current	Current per circuit output, H	- 500	mA
lf	Clamping diode forward current		- 500	mA
Vr #	Clamping diode reverse voltage		50	V
Pd	Power dissipation	Ta = $25^{\circ}$ C, when mounted on board	1.10	W
Topr	Operating temperature		-20 ~ +75	°C
Tstg	Storage temperature		-55 ~ +125	°C

# : Unused Input pins must be connected to GND.

Symbol	Parameter			Limits		
			min	typ	max	Unit
Vs	Supply voltage		0	—	50	V
lo	Output current (Current per 1 circuit when 8 circuits are	Duty Cycle no more than 5%	0	—	-350	mA
10	coming on simultaneously)	Duty Cycle no more than 30%	0	_	-100	ША
Viн	"H" input voltage		2.4	5.0	30	V
VIL	"L" input voltage		0	—	0.2	V

#### **RECOMMENDED OPERATING** (Unless otherwise noted, $Ta = -20 \sim +75^{\circ}C$ )

#### **ELECTRICAL CHARACTERISTICS** (Unless otherwise noted, $Ta = -20 \sim +75^{\circ}C$ )

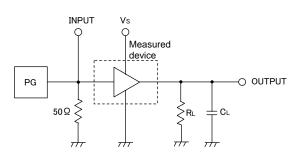
Symbol	Parameter	Test conditions	Limits			Unit
			min	typ*	max	Unit
<b>İ</b> S(leak) #	Supply leak current	Vs = 50V, VI = 0.2V	_	—	100	μA
VCE(sat)	Collector-emitter saturation voltage	Vs = 10V, VI = 2.4V, Io = -350mA	—	1.75	2.4	v
		Vs = 10V, VI = 2.4V, Io = -100mA	-	1.5	2.0	
Iı	Input current	$V_{I} = 5V$	_	0.48	0.75	mA
11		VI = 25V	—	2.8	4.7	
Is	Supply current	Vs = 50V, VI = 5V (all input)	—	5.6	15.0	mA
Vf #	Clamping diode forward voltage	IF = -350mA	-	-1.2	-2.4	V
ĪR	Clamping diode reverse current	V <sub>R</sub> = 50V	_	_	100	μΑ

\* : The typical values are those measured under ambient temperature (Ta) of 25°C. There is no guarantee that these values are obtained under any conditions. # : Unused Input pins must be connected to GND.

#### SWITCHING CHARACTERISTICS (Unless otherwise noted, Ta = $25^{\circ}$ C)

Symbol	Parameter	Test conditions	Limits			Unit
			min	typ	max	Unit
ton	Turn-on time	CL = 15pF(note 1)	—	110		ns
toff	Turn-off time		—	5200	-	ns

#### NOTE 1 TEST CIRCUIT



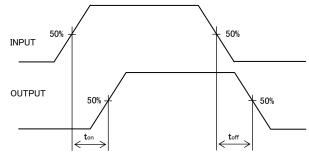
(1) Pulse generator (PG) characteristics: PRR = 1kHz,

tw = 10ms, tr = 6ns, tf = 6ns, Zo = 50  $\Omega\,$  ,Vi = 0 to 2.4V

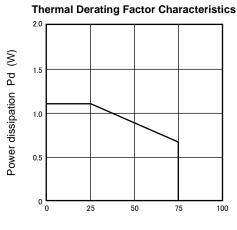
(2) Input-output conditions :  $R_L=30\,\Omega$  , Vs=10V

(3) Electrostatic capacity CL includes floating capacitance at connections and input capacitance at probes

### TIMING DIAGRAM

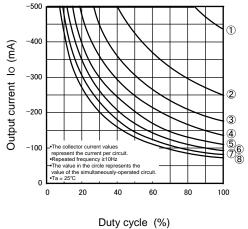


#### **TYPICAL CHARACTERISTICS**

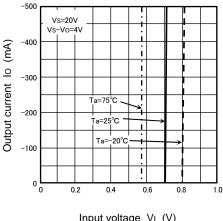


Ambient temperature Ta (°C)

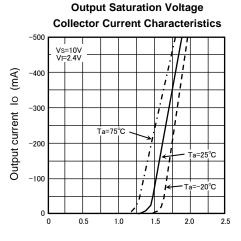






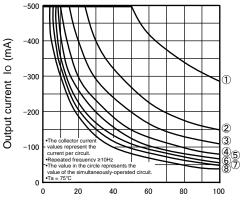




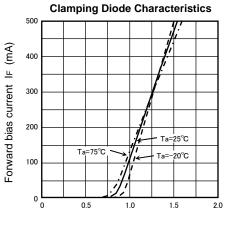


Collector saturation voltage VCE(sat) (V)

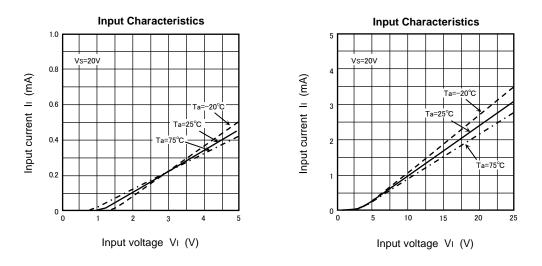




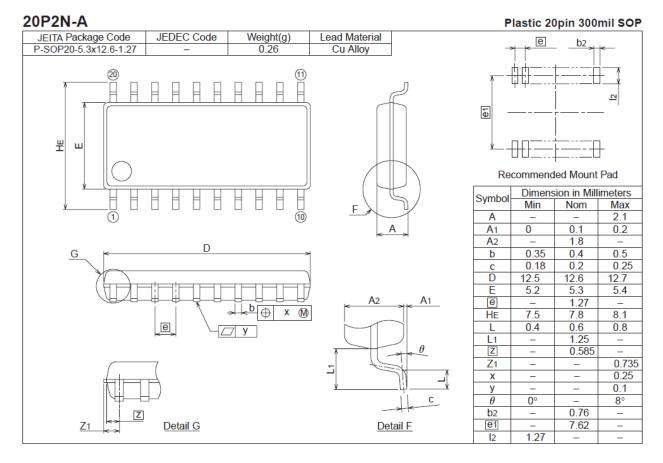




Forward bias voltage VF (V)



#### PACKAGE OUTLINE



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